

Application/Control No.	Applicant(s)/Pate Reexamination	ent under
10/566,502	NAKASHIMA ET AL.	
Examiner	Art Unit	
leie Chali	1611	

	SEARCHED				
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
IDS review Inventor name search West all data bases, patent finder, and Google Scolar search	8/25/2011	IG		